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<b>INFORMATION DISCLOSURE STATEMENT BY APPLICANT</b>  (Use as many sheets as necessary)		Application Number	NEW 10/566216
		Filing Date	January 27, 2006
		First Named Inventor	Yoshinori SHIMIZU
		Art Unit	N/A
		Examiner Name	Not Yet Assigned
Sheet 1 of 1	Attorney Docket Number	5232-0103PUS1	

U.S. PATENT DOCUMENTS					
Examiner Initials*	Cite No. <sup>1</sup>	Document Number	Publication Date	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
		Number-Kind Code <sup>2</sup> (if known)	MM-DD-YYYY		
AA*		US-6,359,918-B1	03-19-2002	Bielas	
AB*		US-2003/0011553-A1	01-16-2003	OZAKI	
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AE*		US-2003/0063462-A1	04-03-2003	SHIMIZU et al.	

FOREIGN PATENT DOCUMENTS					
Examiner Initials*	Cite No. <sup>1</sup>	Foreign Patent Document	Publication Date	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
		Country Code <sup>2</sup> -Number <sup>3</sup> -Kind Code <sup>4</sup> (if known)	MM-DD-YYYY		
BA		JP-2000-112429-A	04-21-2000		ABS
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Examiner Signature	/Liliana Cerullo/	Date Considered	10/27/2008
Birch, Stewart, Kolasch & Birch, LLP		ADM/smt	